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### Title

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### Publication Date

2008-08-11

# **Electronic structure of multiferroic BiFeO<sub>3</sub> by resonant soft-X-ray emission spectroscopy**

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(Received: )

The electronic structure of multiferroic BiFeO<sub>3</sub> has been studied using soft-X-ray emission spectroscopy. The fluorescence spectra exhibit that the valence band is mainly composed of O 2*p* state hybridized with Fe 3*d* state. The band gap corresponding to the energy separation between the top of the O 2*p* valence band and the bottom of the Fe 3*d* conduction band is 1.3 eV. The soft-X-ray Raman scattering reflects the features due to charge transfer transition from O 2*p* valence band to Fe 3*d* conduction band. These findings are similar to the result of electronic structure calculation by density functional theory within the local spin-density approximation that included the effect of Coulomb repulsion between localized *d* states.

## 1. Introduction

Multiferroic materials, such as BiFeO<sub>3</sub> and YMnO<sub>3</sub>, have simultaneous antiferromagnetic, ferroelectric, and/or ferroelastic ordering.<sup>1-6</sup> Coupling between the magnetic and ferroelectric order parameters can lead to magnetoelectric effects, in which the magnetization can be tuned by an applied electric field and vice versa. In particular, BiFeO<sub>3</sub> is a suitable candidate for attaining ferroelectric and antiferromagnetic domain couplings at room temperature (RT), owing to its high Curie temperature of 1100°C and its high Neel temperature of ~370°C.<sup>2,3</sup> The crystal structure of BiFeO<sub>3</sub> single crystal is a rhombohedrally distorted perovskite structure, which belongs to the space group *R3C* with the unit cell parameters  $a=3.96 \text{ \AA}$  and  $\alpha=89.4^\circ$ .<sup>4</sup> In term of ferroelectricity, the BiFeO<sub>3</sub> single crystal has a spontaneous polarization of  $3.5 \mu\text{C}/\text{cm}^2$  along the  $\langle 100 \rangle$  direction and of  $6.1 \mu\text{C}/\text{cm}^2$  along the  $\langle 111 \rangle$  direction.<sup>5</sup> The polarization is strongly enhanced in thin film forms.

A large polarization above  $\sim 50 \mu\text{C}/\text{cm}^2$  has been observed in high quality single crystal and thin films fabricated by pulsed laser deposition (PLD) and chemical solution deposition (CSD).<sup>6-10</sup> Furthermore, in recent years, Kim *et al.* has reported that the BiFeO<sub>3</sub> epitaxial film has the highest polarization of  $70\sim 80 \mu\text{C}/\text{cm}^2$  on SrTiO<sub>3</sub> (001) substrates with SrRuO<sub>3</sub> bottom electrode.<sup>{ 11 }</sup> Therefore, BiFeO<sub>3</sub> thin film is expected for application of a high-density ferroelectric random-access memory because of its large polarization and low crystallization temperature. However, a major problem of BiFeO<sub>3</sub> thin film is low electrical resistivity, which affects the measurement of dielectric/ferroelectric properties at room temperature. The low electrical resistivity of BiFeO<sub>3</sub> thin films is attributed to the valence fluctuations of Fe ions (Fe<sup>2+</sup> or Fe<sup>3+</sup>), creating oxygen vacancies for charge compensation.<sup>12,13</sup> The BiFeO<sub>3</sub> thin film needs

the high electrical resistivity in order to obtain good ferroelectricity. Therefore, the formation of solid solutions with other perovskite materials as well as the substitution of impurity atoms at the Bi and Fe sites have been attempted by many scientists.<sup>14-18</sup>

In recent years, BiFeO<sub>3</sub> has been refocused in research area of solid state physics.<sup>1,6,19,20</sup> Neaton and co-workers have studied theoretically the ground state structural and electronic properties of BiFeO<sub>3</sub> using the density functional theory (DFT) within the local spin density approximation (LSDA).<sup>19</sup> In this calculation, a large ferroelectric polarization of 90~100  $\mu\text{C}/\text{cm}^2$  is predicted, consistent with the large atomic displacements in the ferroelectric phase and with recent experimental reports.<sup>7-10</sup> The electronic structure calculation of BiFeO<sub>3</sub> with the space group *R3C* shows an antiferromagnetic insulating-like nature and hybridization effect between Fe 3*d* and O 2*p* in the valence band.<sup>19</sup> The authors believe that the electrical properties of BiFeO<sub>3</sub> are closely related to the electronic structure. However, the electronic structure of BiFeO<sub>3</sub> has not been clarified experimentally thus far.

In this study, the electronic structure of BiFeO<sub>3</sub> bulk crystal has been measured by X-ray absorption spectroscopy (XAS) and soft-X-ray emission spectroscopy (SXES). Although photoemission spectroscopy (PES) has been a powerful method of studying of the electronic structure of total density-of-state (DOS), PES is surface sensitive, since the mean free path of an electron is very short. Additionally, the PES cannot study the electronic structure of insulating material due to charging up. Therefore, it is difficult to study the electronic structure of BiFeO<sub>3</sub> by PES. SXES is related directly to the occupied DOS.<sup>21</sup> SXES detects the electronic structure of the bulk state owing to the long mean free path of the soft-X-rays. Furthermore, the partial-DOS (PDOS) localized at an atom can be obtained from SXES spectra, because SXES has a clear

selection rule regarding the angular momentum due to dipole selection. XAS is related directly to the unoccupied DOS.<sup>22</sup> This optical process is a local process, because of the localized core state. It is governed by the dipole selection rules so that XAS provides spectra related to the site- and symmetry-selected DOS. In this paper, the authors discuss about the origin of the multiferroic behavior of BiFeO<sub>3</sub> by comparing with non-multiferroic material.

## 2. Experimental

BiFeO<sub>3</sub> sample was prepared by a solid state reaction using conventional milling and firing techniques. Bi<sub>2</sub>O<sub>3</sub> and Fe<sub>2</sub>O<sub>3</sub> powders corresponding to BiFeO<sub>3</sub> composition with 0.75 mol% of excess Bi was weighed and thoroughly mixed using stabilized ZrO<sub>2</sub> balls in ethanol. The mixtures were dried, pressed, and sintered at 750°C for 2 h at an increment of 10°C/min. In this case, polyvinyl alcohol was used as a binder. The powder compacts were subsequently sintered at 900~1000°C for 3~10 h at an increment of 10°C/min. The prepared samples were characterized by X-ray diffraction with CuK $\alpha$  radiation using a monochromator. Details have been reported in ref. 18.

XAS and SXES spectra were measured at beamline 7.0.1 at the Advanced Light Source (ALS), Lawrence Berkeley National Laboratory, U.S.A. This beamline is equipped with a spherical grating monochromator.<sup>23</sup> The XAS spectra were obtained by recording the fluorescence yield with 0.2 eV resolution and normalized to the photocurrent from a clean gold mesh to correct the intensity fluctuation of the excitation beam, which reflects the bulk state. SXES spectra were recorded using a Nordgren-type grazing-incidence spherical grating spectrometer.<sup>24,25</sup> The incidence

angle of the photon beam was  $20^\circ$  to the sample surface in order to reduce the self-absorption effect. The  $\text{BiFeO}_3$  sample was fractured before measurement. The SXES spectra were normalized by measurement time and beam current. The SXES spectrometer was set to have a resolution of 0.5 eV for O  $1s$  core level and 0.7 eV for Fe  $2p$  core level.

### 3. Results and Discussion

Figure 1 shows the Fe  $2p$  XAS spectrum of  $\text{BiFeO}_3$ . The spectrum consists of two parts derived from the spin-orbit split of  $L_3$  ( $2p_{3/2}$ ) and  $L_2$  ( $2p_{1/2}$ ) states. They are further split into the  $t_{2g}$  and  $e_g$  states due to the octahedral ligand field. The crystal field splitting (10Dq) corresponding to the energy separation between  $t_{2g}$  and  $e_g$  states is 1.4 eV. The spectral shape, peak positions and 10Dq of  $\text{BiFeO}_3$  are similar to those of  $\text{La}_{1-x}\text{Sr}_x\text{FeO}_3$ , which was theoretically calculated assuming a high-spin  $t_{2g}^3e_g^2$  ground state.<sup>26,27</sup> This fact indicates that the  $\text{BiFeO}_3$  is mainly  $3d^5$  in the ground state of bulk. In recent years, Béa *et al.* have reported the Fe  $2p$  XAS spectra of  $\text{BiFeO}_3$  thin film.<sup>28</sup> The peak position of this report accords with that of Fig. 1. The intensity ratio ( $I(L_2)/I(L_3)$ ) of  $L_3$  and  $L_2$  of this report is different from that of Fig. 1. Although the ratio of Fig. 1 is approximately 0.5, the ratio of this report is smaller than 0.5, indicating the effect of surface state. The vertical bars, which are labeled from 1 to 8, indicate the selected photon energies for resonant SXES measurements.

Figure 2 shows the Fe  $2p$  SXES spectra of  $\text{BiFeO}_3$  excited at photon energies labeled in Fig. 1. It is well known that the Fe  $2p$  emission reflects the Fe  $3d$  PDOS. An arrow shown each spectrum is attributed to elastic scattering of the excitation photon. The elastic peak is enhanced at the excitation energy corresponding to the  $e_g$  absorption

peak of  $L_3$ , spectrum 3 of Fig. 2. The peak intensity decreases with increasing excitation energy for spectra 4 to 7. On the other hand, several features of vertical dashed lines with same energy separations from the excitation energy are attributed to the soft-X-ray Raman scattering (or inelastic scattering). The details of soft-X-ray Raman scattering will discuss in Figs. 4 and 5.

The spectrum 8 excited at  $h\nu=740$  eV is an off-resonance spectrum attributed to the normal Fe  $3d \rightarrow 2p$  fluorescence spectrum. This spectrum may indicate that the Fe  $3d$  state hybridizes with O  $2p$  state in the valence band. Four solid lines show the fluorescence bands by  $L_3$  and  $L_2$  excitations.

Figure 3 shows the comparison between Fe  $2p$  fluorescence spectrum by  $L_3$  excitation and the theoretical Fe  $3d$  PDOS calculated by Neaton *et al.*,<sup>19,20</sup> Neaton has calculated the DOS curves using DFT within LSDA.<sup>19</sup> Furthermore, the effect of Coulomb repulsion ( $U_{\text{eff}}$ ) between localized Fe  $3d$  states is also included by adding a Hubbard-like term to the effective potential. The Fe  $3d$  PDOS at  $U_{\text{eff}}=0$  eV distributes at the top of the valence band. However, the distribution of Fe  $3d$  PDOS at  $U_{\text{eff}}=2$  eV shifts higher energy side than that at  $U_{\text{eff}}=0$  eV. The distribution of Fe  $3d$  PDOS estimated by the Fe  $2p$  fluorescence spectrum is similar to that calculated at  $U_{\text{eff}}=2$  eV, although the bandwidth of the calculated DOS is different from that of Fe  $2p$  fluorescence spectrum by the effect of energy resolution of this system. The above results indicate that the  $U_{\text{eff}}$  between localized Fe  $3d$  states also plays an important role in the electrical properties of BiFeO<sub>3</sub>.

Figure 4 shows the SXES spectra of BiFeO<sub>3</sub>, where the abscissa is the Raman shift (or energy loss) from the elastic scattering. The elastic scattering peak is located at 0 eV. The Fe  $3d \rightarrow 2p$  fluorescence peaks shown by six solid bars shift to the higher

energy with increasing excitation energy. Several soft-X-ray Raman scattering peaks shown as vertical dashed lines  $\alpha$ ,  $\beta$ ,  $\chi$ ,  $\delta$ ,  $\varepsilon$ , and  $\phi$  are observed at 3.2, 4.5, 6.6, 7.8, 8.4, and 9.7 eV, respectively, from the elastic scattering peak. The soft-X-ray Raman scattering peaks excited at the  $L_3$  absorption edge overlap with the Fe  $3d \rightarrow 2p$  fluorescence peaks. The spectrum 1 excited just below the Fe  $2p$  threshold show an apparent feature at a lower energy than the elastic scattering. Since the excitation energy is lower than the binding energy of Fe  $2p$  core level, the spectrum 1 is attributed to normal Raman scattering, where the intermediate state is a virtual state. The elementary excitation of the Raman scattering is considered to correspond to the valence band transition. Therefore, the energy positions of these Raman scattering peaks may correspond to the transition between the valence and conduction bands.

Figure 5 shows the O  $1s$  and Fe  $2p$  SXES spectra and O  $1s$  XAS spectrum of  $\text{BiFeO}_3$ , where the abscissa is the relative energy to Fermi level ( $E_F$ ). The O  $1s$  and Fe  $2p$  SXES spectra were measured at the excitation energies of 540 eV and 740 eV, respectively. The Fe  $2p$  and O  $1s$  SXES spectra, which correspond to fluorescence spectra, reflect the Fe  $3d$  and O  $2p$  PDOS, respectively, in the valence band. The energy position of O  $2p$  state overlaps with that of Fe  $3d$  state. This result indicates that the Fe  $3d$  state hybridizes with O  $2p$  state in the valence band. The O  $2p$  valence band has three structures labeled as A, B and C. The Fe  $3d$  contribution is more significant in the B and C peaks, where the O  $2p$  states have a larger admixture of Fe  $3d$  states. The A peak corresponds to the O  $2p$  states, which are not hybridized with the Fe derived states. On the other hand, from the dipole selection rules, it is understood that the O  $1s$  XAS spectrum of Fe oxides corresponds to transitions from O  $1s$  to O  $2p$ .<sup>26</sup> The conduction band has three structures shown as dashed curves from Gaussian



fitting. The a and b peaks correspond to the  $t_{2g}$  and  $e_g$  states, respectively, of Fe 3d state. The c peak is considered to be Bi 6sp state. The energy separation between a and b peaks accords with the result of Fe 2p XAS spectrum in Fig. 1. The band gap corresponding to the energy separation between the top of the valence band and the bottom of the conduction band is estimated to be 1.3 eV by concerning the resolution in this measurement system. In LSDA calculation,<sup>19,20</sup> the band gap has been estimated to be 1.3 eV at  $U_{\text{eff}}=2$  eV, although the gap is 0.4 eV at  $U_{\text{eff}}=0$  eV. The value of BiFeO<sub>3</sub> is smaller than those of other ferroelectric material such as Bi<sub>4</sub>Ti<sub>3</sub>O<sub>12</sub> and Pb(Zr,Ti)O<sub>3</sub>.<sup>29,30</sup> The small band gap contributes to the low electrical resistivity of BiFeO<sub>3</sub> bulk crystal. In recent years, Ihlefeld *et al.* has reported that the epitaxial BiFeO<sub>3</sub> thin film on SrTiO<sub>3</sub> substrate has the band gap of 2.74 eV.<sup>31</sup> The discrepancy is considered to originate the difference of electron correlation energy between thin film and ceramic sample because the band gap is defined by the energy separation between Fe 3d valence band and Fe 3d conduction band. The BFO ceramics sample used in this study has valence fluctuations of Fe ions (Fe<sup>2+</sup> or Fe<sup>3+</sup>), creating oxygen vacancies for charge compensation, as shown in Fig. 1. Thus, the band gap of BFO ceramics sample may decrease due to the decrease of electron correlation energy with oxygen vacancies and valence fluctuations of Fe ions, although the evidence has not been clarified thus far.

Here, the authors estimate the six soft-X-ray Raman scattering peaks ( $\alpha$ ,  $\beta$ ,  $\chi$ ,  $\delta$ ,  $\varepsilon$ , and  $\phi$ ) in Fig. 4. The  $\alpha$  (or  $\beta$ ) correspond to the transitions from A to a (or b). The  $\chi$  (or  $\delta$ ) correspond to the transitions from B to a (or b). The  $\varepsilon$  (or  $\phi$ ) correspond to the transitions from C to a (or b). These agreements indicate that the six soft-X-ray Raman scattering peaks is attributed to the charge transfer (CT) transitions from the

occupied O  $2p$  to unoccupied Fe  $3d$  states. A soft-X-ray Raman scattering peak labeled as  $\theta$  is strongly observed at  $\sim 5.5$  eV in Fig. 3. This peak may correspond to the CT transition from the occupied O  $2p$  state (B peak) to the bottom of the conduction band, although the evidence has not been clarified thus far. On the other hand, soft-X-ray Raman scattering peaks due to the  $d-d$  transition between the  $3d$  valence and conduction bands are observed in SXES spectra of lightly  $3d$  transition metal compounds.<sup>32-37</sup> In particular, the  $t_{2g}$  resonant SXES spectra exhibit the Raman scattering due to  $d-d$  transition corresponding to the half of electron correlation energy.<sup>34,36</sup> However, the authors cannot estimate such a scattering from the spectra of Fig. 4, although that may exist.

Finally, the authors discuss about the origin of multiferroic behavior of BiFeO<sub>3</sub> by comparing with non-multiferroic material such as Bi<sub>4</sub>Ti<sub>3</sub>O<sub>12</sub> (BIT) and PZT.<sup>29,30</sup> In both BIT and PZT, the valence band consists of O  $2p$  state hybridized with Ti  $3d$  state and the conduction band consists of Ti  $3d$  state. Furthermore, these SXES data exhibit the several soft-X-ray Raman scattering peaks, which attribute to CT transitions. These situations are similar to BiFeO<sub>3</sub>. The difference between BiFeO<sub>3</sub> and BIT (or PZT) is electron number of  $3d$  state and origin of band gap. The band gaps of BIT and PZT with  $3d^0$  configuration is determined by the energy separation between the top of O  $2p$  valence band and the bottom of Ti  $3d$  conduction band.<sup>29,30</sup> The band gap of BiFeO<sub>3</sub> is determined by the energy separation between the top of O  $2p$ -Fe  $3d$  mixed valence band and the bottom of Fe  $3d$  conduction band. On one hand, the band gap is attributed to the electron correlation between Fe  $3d$  states. Such a correlation does not exist in BIT and PZT. Although the details of origin have not been clarified in this study, the electron correlation between  $3d$  states may be closely related with the origin

of multiferroic of BiFeO<sub>3</sub>.

#### **4. Conclusion**

The authors have studied the electronic structure of BiFeO<sub>3</sub> using SXES and XAS. The Fe in BiFeO<sub>3</sub> has high-spin  $t_{2g}^3 e_g^2$  ground state. The conduction band consists of  $t_{2g}$  and  $e_g$  subbands of Fe 3*d* state. The valence band consists of O 2*p* state hybridized with Fe 3*d* state. The band gap corresponding to the energy separation between the top of the O 2*p*-Fe 3*d* valence band and the bottom of the Fe 3*d* conduction band is 1.3 eV. The six soft-X-ray Raman scattering peaks reflect the features due to CT transition from O 2*p* valence band to Fe 3*d* conduction band. These findings are similar to the electronic structure by DFT within LSDA method that included the effect of  $U_{\text{eff}}$ .

#### **Acknowledgements**

This work was supported by a Grant-In-Aid for Scientific Research (B) from the Ministry of Education, Culture, Sports, Science and Technology, Japan. The Advanced Light Source is supported by the Director, Office of Science, Office of Basic Energy Sciences, of the U.S. Department of Energy under Contract No. DE-AC02-05CH11231.

## References

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<sup>1</sup> T. Kimura, T. Goto, H. Shintani, K. Ishizaka, T. Arima, and Y. Tokura, *Nature (London)* **426**, 55 (2003).

<sup>2</sup> G. Smolenskii, V. Isupov, A. Agranovskaya, and N. Kranik, *Sov. Phys. Solid State* **2**, 2651 (1961).

<sup>3</sup> G. Smolenskii, V. Yudin, E. Sher, and Y. E. Stolypin, *Sov. Phys. JETP* **16**, 622 (1963).

<sup>4</sup> F. Kubel and H. Schmid: *Acta Crystallogr., Sect. B* **46**, 698 (1990).

<sup>5</sup> J. R. Teague, R. Gerson, and W. J. James, *Solid State Commun.* **8**, 1073 (1970).

<sup>6</sup> D. Lebeugle, D. Colson, A. Forget, M. Viret, P. Bonville, J. F. Marucco, and S. Fusil, *Phys. Rev. B* **76**, 024116 (2007).

<sup>7</sup> J. Wang, J. B. Neaton, H. Zheng, V. Nagarajan, S. B. Ogale, B. Liu, D. Viehland, V. Vaithyanathan, D. G. Schlom, U. V. Waghmare, N. A. Spaldin, K. M. Rabe, M. Wuttig, and R. Ramesh, *Science* **299**, 1719 (2003).

<sup>8</sup> J. Li, J. Wang, M. Wuttig, R. Ramesh, N. Wang, B. Ruetter, A. P. Pyatakov, A. K. Zvezdin, and D. Viehland, *Appl. Phys. Lett.* **84**, 5261 (2004).

<sup>9</sup> S. K. Singh and H. Ishiwara: *Jpn. J. Appl. Phys.* **44**, L734 (2005).

<sup>10</sup> K. Y. Yun, D. Ricinchi, T. Kanashima, M. Noda, and M. Okuyama, *Jpn. J. Appl. Phys.* **43**, L647 (2004).

<sup>11</sup> D. H. Kim, H. N. Lee, M. D. Biegalski, and H. M. Christen, *Appl. Phys. Lett.* **92**, 012911 (2008).

<sup>12</sup> V. R. Palkar, J. John, and R. Pinto, *Appl. Phys. Lett.* **80**, 1628 (2002).

<sup>13</sup> Y. P. Wang, L. Zhou, M. F. Zhang, X. Y. Chen, J. M. Liu, and Z. G. Liu, *Appl. Phys. Lett.* **84**, 1731 (2004).

<sup>14</sup> K. Ueda, H. Tabata, and T. Kawai, *Appl. Phys. Lett.* **75**, 555 (1999).

<sup>15</sup> M. Mahesh Kumar, A. Srinivas, and S. V. Suryanarayana, *J. Appl. Phys.* **87**, 855 (2000).

<sup>16</sup> W. Sakamoto, H. Yamazaki, A. Iwata, T. Shimura, and T. Yogo, *Jpn. J. Appl. Phys.* **45**, 7315 (2006).

<sup>17</sup> S. Yasui, H. Uchida, H. Nakaki, K. Nishida, H. Funakubo and S. Koda, *Appl. Phys. Lett.* **90**, 262902 (2007).

<sup>18</sup> N. Itoh, T. Shimura, W. Sakamoto, and T. Yogo, *Ferroelectrics* **356**, 19 (2007).

<sup>19</sup> J. B. Neaton, C. Ederer, U. V. Waghmare, N. A. Spaldin, and K. M. Rabe, *Phys. Rev. B* **71**, 014113 (2005).

<sup>20</sup> P. Baettig, C. Ederer, and N. A. Spaldin, *Phys. Rev. B* **72**, 214105 (2005).

<sup>21</sup> A. Kotani and S. Shin, *Rev. Mod. Phys.* **73**, 203 (2001)

- <sup>22</sup> J. C. Fuggle and J. E. Inglesfield, “*Unoccupied Electronic States*” Springer-Verlag (1991).
- <sup>23</sup> J. Nordgren and R. Nyholm, Nucl. Instrum. Methods Phys. Res. A **246**, 242 (1986).
- <sup>24</sup> J. Nordgren, G. Bray, S. Cramm, R. Nyholm, J. E. Rubensson, and N. Wassdahl, Rev. Sci. Instrum. **60**, 1690 (1989).
- <sup>25</sup> J.-H. Guo, Y. Luo, A. Augustsson, J.-E. Rubensson, C. S  the, H.   gren, H. Siegbahn, and J. Nordgren, Phys. Rev. Lett. **89**, 137402 (2002).
- <sup>26</sup> M. Abbate, F. M. F. de Groot, J. C. Fuggle, A. Fujimori, O. Strebel, F. Lopez, M. Domke, and G. Kaindl, G. A. Sawatzky, M. Takano, Y. Takeda, H. Eisaki, and S. Uchida, Phys. Rev. B **46**, 4511 (1992).
- <sup>27</sup> H. Wadati, D. Kobayashi, H. Kumigashira, K. Okazaki, T. Mizokawa, A. Fujimori, K. Horiba, M. Oshima, N. Hamada, M. Lippmaa, M. Kawasaki, and H. Koinuma, Phys. Rev. B **71**, 035108 (2005).
- <sup>28</sup> H. B  a, M. Bibes, S. Fusil, K. Bouzehouane, Eric Jacquet, K. Rode, P. Bencok and A. Barth  l  my, Phys. Rev. B **74**, 020101 (2006).
- <sup>29</sup> T. Higuchi, M. Tanaka, K. Kudoh, T. Takeuchi, Y. Harada, S. Shin, and T. Tsukamoto, Jpn. J. Appl. Phys. **40**, 5803 (2001).
- <sup>30</sup> T. Higuchi, T. Tsukamoto, T. Hattori, Y. Honda, S. Yokoyama, and H. Funakubo, Jpn. J. Appl. Phys. **44**, 6923 (2005).
- <sup>31</sup> J. F. Ihlefeld, N. J. Podraza, Z. K. Liu, R. C. Rai, X. Xu, T. Heeg, Y. B. Chen, J. Li, R. W. Collins, J. L. Musfeldt, X. Q. Pan, J. Schubert, R. Ramesh, and D. G. Schlom, Appl. Phys. Lett. **92**, 142908 (2008).
- <sup>32</sup> S. M. Butorin, J. -H. Guo, M. Magnuson, P. Kuiper, and J. Nordgren, Phys. Rev. B **54**, 4405 (1996).
- <sup>33</sup> S. M. Butorin, D. C. Mancini, J. -H. Guo, N. Wassdahl, J. Nordgren, M. Nakazawa, S. Tanaka, T. Uozumi, A. Kotani, Y. Ma, K. E. Myano, B. A. Karlin, and D. K. Shuh, Phys. Rev. Lett. **77**, 574 (1996).
- <sup>34</sup> T. Higuchi, T. Tsukamoto, M. Watanabe, M. M. Grush, T. A. Callcott, R. C. Perera, D. L. Ederer, Y. Tokura, Y. Harada, Y. Tezuka, and S. Shin, Phys. Rev. B **60**, 7711 (1999).
- <sup>35</sup> J. -H. Guo, S. M. Butorin, N. Wassdahl, J. Nordgren, P. Berastegut, and L.-G. Johansson, Phys. Rev. B **61**, 9140 (2000).
- <sup>36</sup> M. Magnuson, S. M. Butorin, J. -H. Guo, and J. Nordgren, Phys. Rev. B **65**, 205106 (2002).
- <sup>37</sup> T. Higuchi, D. Baba, T. Takeuchi, T. Tsukamoto, Y. Taguchi, Y. Tokura, A. Chainani, and S. Shin, Phys. Rev. B **68**, 104420 (2003).

## Figure captions

Fig. 1 Fe 2*p* XAS spectrum of BiFeO<sub>3</sub>. The labels (1-8) indicate the photon energies, where the Fe 2*p* SXES spectra were measured.

Fig. 2 Fe 2*p* SXES spectra of BiFeO<sub>3</sub> excited at various photon energies indicated Fig. 1. Arrow shows the energy position of the excitation photon energy. Four vertical solid lines are the energy positions of Fe 3*d*→2*p* fluorescence.

Fig. 3 (a) Fe 2*p* fluorescence spectrum of BiFeO<sub>3</sub>, (b) Fe 3*d* PDOS curves calculated by Neaton *et al.* (ref. 18).

Fig. 4 Fe 2*p* SXES spectra of BiFeO<sub>3</sub> presented on a relative emission energy scale compared to the elastic scattering. Vertical dashed lines show the positions of inelastic scattering.

Fig. 5 Fe 2*p*, O 1*s* fluorescence spectra and O 1*s* XAS spectrum of BiFeO<sub>3</sub> presented on a relative energy compared to  $E_F$ . The energy separation between the top of the valence band and the bottom of conduction band reflects the band gap ( $E_g$ ) of BiFeO<sub>3</sub>. Dashed curves are the details of conduction band that estimated from Gaussian fitting.

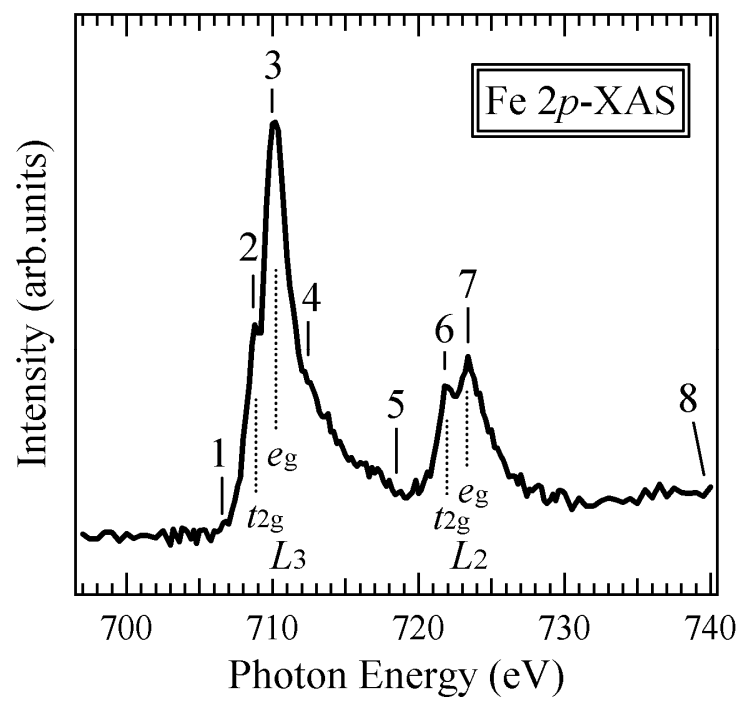


Fig. 1 : T. Higuchi *et al.*

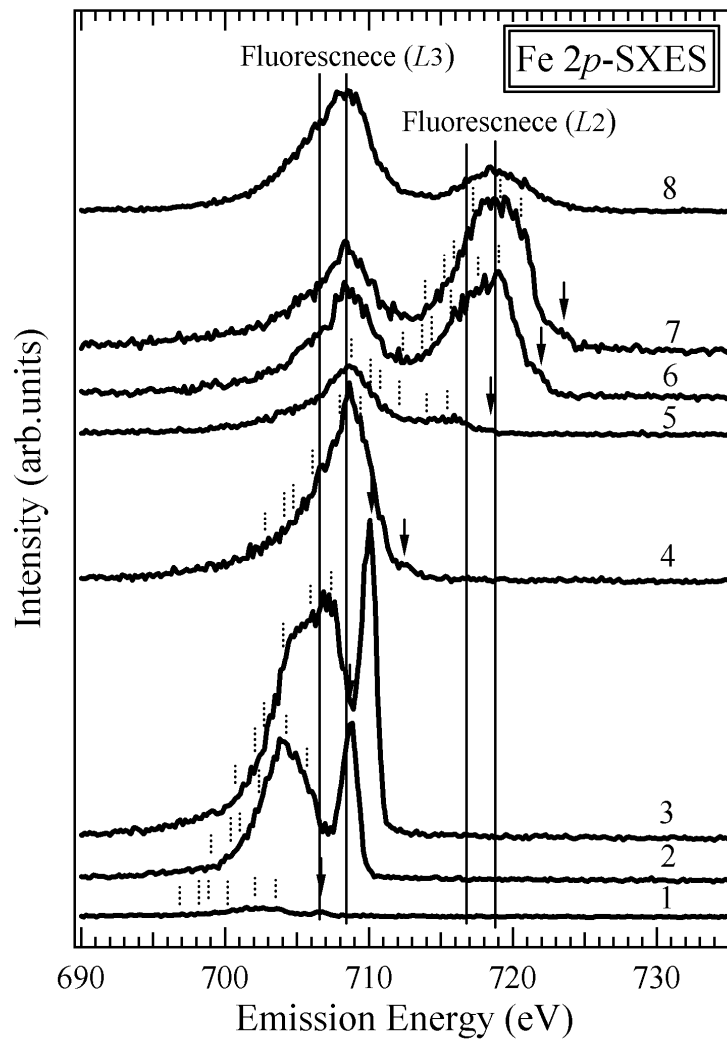


Fig. 2 : T. Higuchi *et al.*



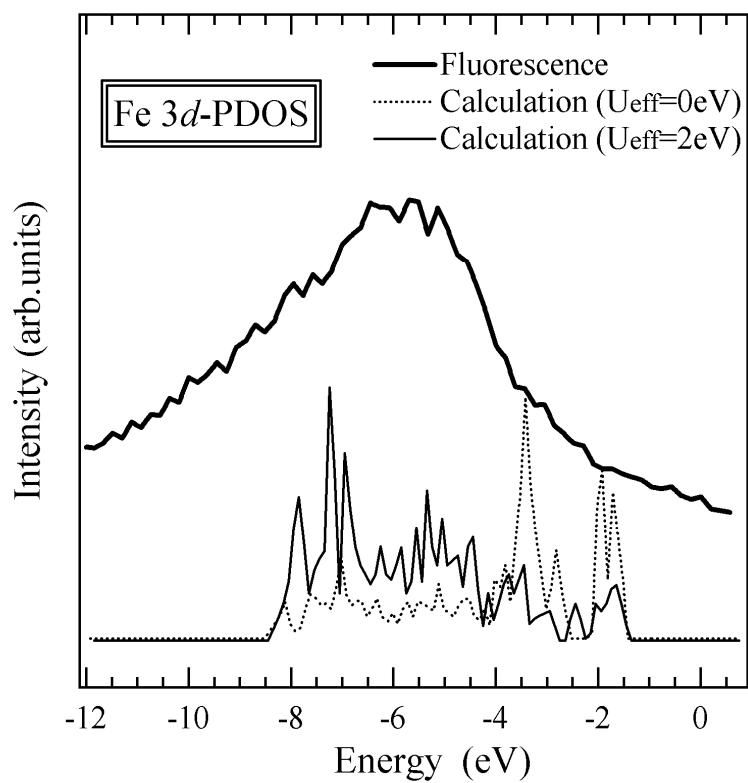


Fig. 3 : T. Higuchi *et al.*

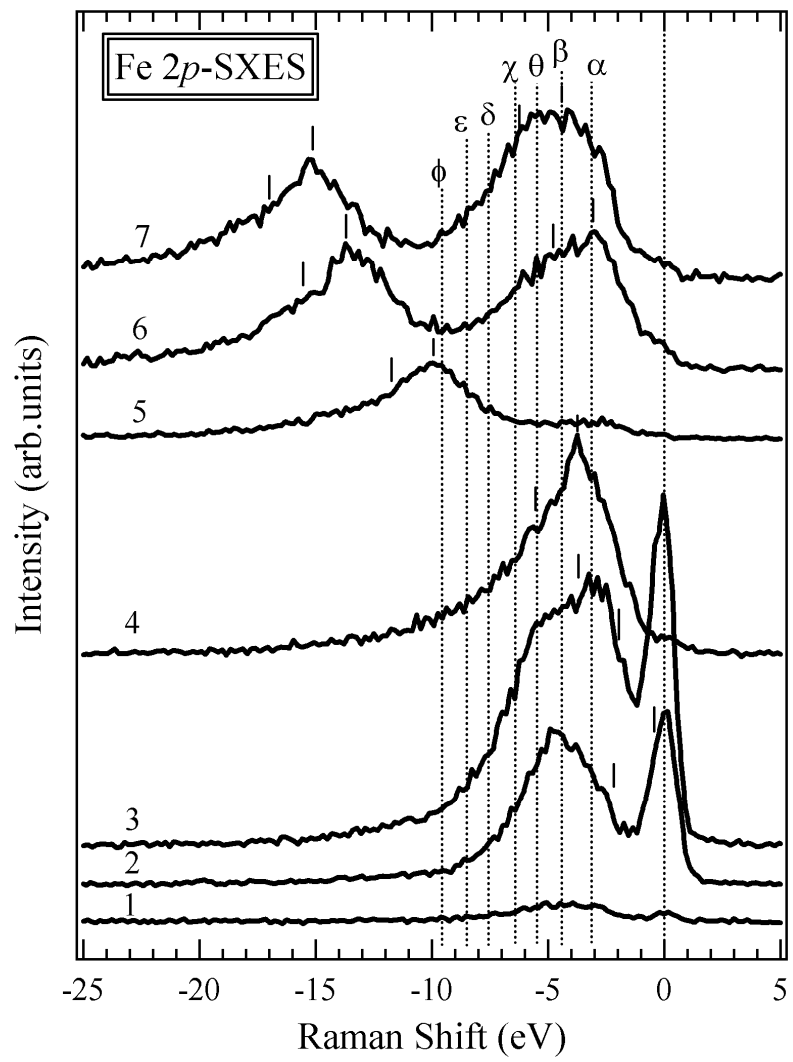


Fig. 4 : T. Higuchi *et al.*

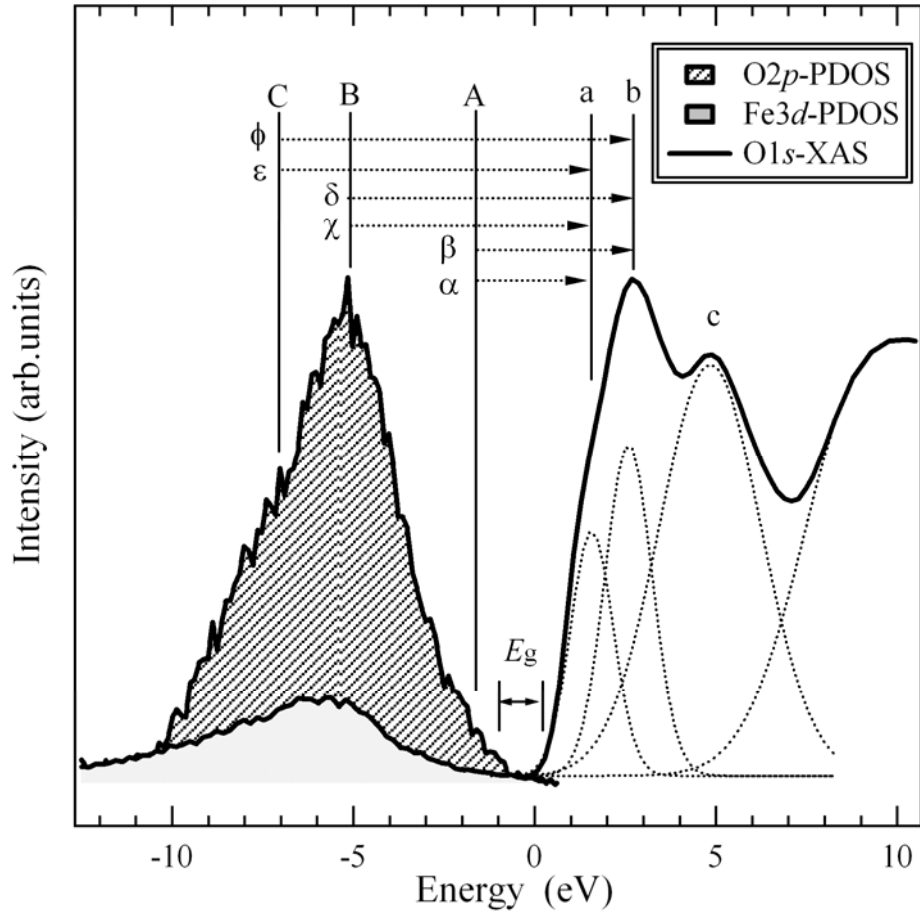


Fig. 5 : T. Higuchi *et al.*